

## MAX11108

## Tiny, 2.1mm x 1.6mm, 3Msps, Low-Power, Serial 12-Bit ADC

### General Description

The MAX11108 is a tiny (2.1mm x 1.6mm), 12-bit, compact, high-speed, low-power, successive approximation analog-to-digital converter (ADC). This high-performance ADC includes a high-dynamic range sample-and-hold and a high-speed serial interface. This ADC accepts a full-scale input from 0V to the power supply or to the reference voltage.

The MAX11108 features a single-ended analog input connected to the ADC core. The device also includes a separate supply input for data interface and a dedicated input for reference voltage.

The MAX11108 "communicates" from 1.5V to  $V_{DD}$  and operates from a 2.2V to 3.6V supply. The device consumes only 6.6mW at 3Msps and includes full power-down mode and fast wake-up for optimal power management and a high-speed 3-wire serial interface. The 3-wire serial interface directly connects to SPI/QSPI™/MICROWIRE® devices without external logic.

Excellent dynamic performance, low voltage, low power, ease of use, and extremely small package size make this converter ideal for portable battery-powered data-acquisition applications, and for other applications that demand low-power consumption and minimal space.

The MAX11108 is available in an ultra-TQFN (2.1mm x 1.6mm) package, and operates over the  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  temperature range.

### Applications

- Instrument Data Acquisition
- Mobile
- Portable Data Logging
- Medical Instrumentation
- Battery-Operated Systems
- Communication Systems

QSPI is a trademark of Motorola, Inc.

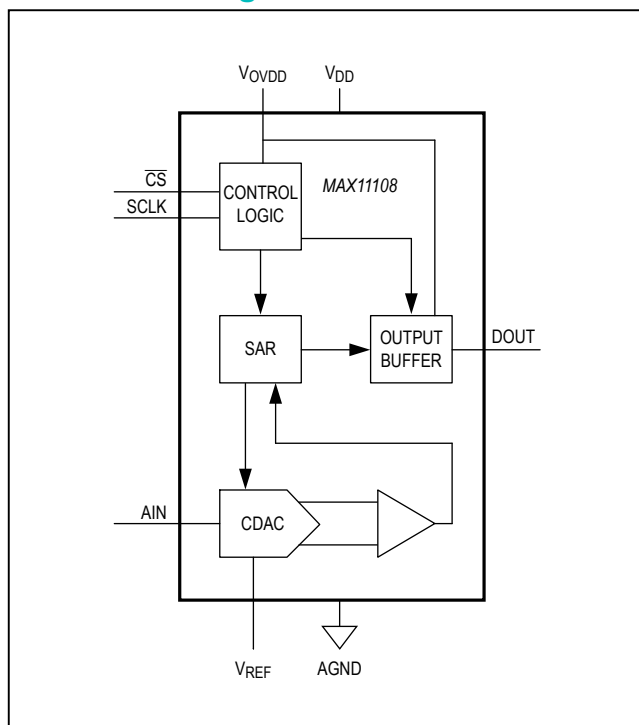
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### Benefits and Features

- Compact ADC Saves Space
  - Single-Ended Analog Input 12-Bit Resolution ADC
  - 3Msps Conversion Rate with No Pipeline Delay
  - 73dB SNR
  - 10-Pin, Ultra-TQFN ( $\mu\text{DFN}$ ), 2.1mm x 1.6mm Package
- Low Power Consumption Extends Battery Life
  - 6.6mW at 3Msps
  - Very Low Power Consumption at  $2.5\mu\text{A/ksp}$ s
  - $1.3\mu\text{A}$  Power-Down Current
  - 2.2V to 3.6V Supply Voltage
- Variable I/O Voltage Range of 1.5V to 3.6V Eases Interface to Microcontrollers
- SPI-/QSPI-/MICROWIRE-Compatible Serial Interface Directly Connects to 1.5V, 1.8V, 2.5V, or 3V Digital System

### Functional Diagram



## Absolute Maximum Ratings

$V_{DD}$  to AGND ..... -0.3V to +4V  
 REF, OVDD, AIN to AGND ..... -0.3V to the lower of  
 ..... ( $V_{DD} + 0.3V$ ) and +4V  
 CS, SCLK, DOUT TO AGND ..... -0.3V to the lower of  
 ..... ( $V_{OVDD} + 0.3V$ ) and +4V  
 Input/Output Current (all pins) ..... 50mA

Continuous Power Dissipation ( $T_A = +70^\circ\text{C}$ )  
 Ultra TQFN (derate 9mW/ $^\circ\text{C}$  above  $+70^\circ\text{C}$ ) ..... 722mW  
 Operating Temperature Range .....  $-40^\circ\text{C}$  to  $+125^\circ\text{C}$   
 Junction Temperature .....  $+150^\circ\text{C}$   
 Storage Temperature Range .....  $-65^\circ\text{C}$  to  $+150^\circ\text{C}$   
 Lead Temperature (soldering, 10s) .....  $+300^\circ\text{C}$   
 Soldering Temperature (reflow) .....  $+260^\circ\text{C}$

*Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.*

## Package Thermal Characteristics (Note 1)

Ultra TQFN

Junction-to-Ambient Thermal Resistance ( $\theta_{JA}$ ) .....  $110.8^\circ\text{C/W}$

Junction-to-Case Thermal Resistance ( $\theta_{JC}$ ) .....  $62.1^\circ\text{C/W}$

**Note 1:** Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to [www.maximintegrated.com/thermal-tutorial](http://www.maximintegrated.com/thermal-tutorial).

## Electrical Characteristics

( $V_{DD} = 2.2V$  to  $3.6V$ ,  $V_{REF} = V_{DD}$ ,  $V_{OVDD} = V_{DD}$ ,  $f_{SCLK} = 48\text{MHz}$ , 50% duty cycle, 3Msps,  $C_{DOUT} = 10\text{pF}$ ,  $T_A = -40^\circ\text{C}$  to  $+125^\circ\text{C}$ , unless otherwise noted. Typical values are at  $T_A = +25^\circ\text{C}$ .)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
<b>DC ACCURACY</b>						
Resolution			12			Bits
Integral Nonlinearity	INL				$\pm 1$	LSB
Differential Nonlinearity	DNL	No missing codes			$\pm 1$	LSB
Offset Error	OE			$\pm 0.3$	$\pm 3$	LSB
Gain Error	GE	Excluding offset and reference errors		$\pm 1$	$\pm 3$	LSB
Total Unadjusted Error	TUE			$\pm 1.5$		LSB
<b>DYNAMIC PERFORMANCE (<math>f_{AIN} = 1\text{MHz}</math>)</b>						
Signal-to-Noise and Distortion	SINAD		70	72		dB
Signal-to-Noise Ratio	SNR		70.5	72		dB
Total Harmonic Distortion	THD			-85	-75	dB
Spurious-Free Dynamic Range	SFDR		76	85		dB
Intermodulation Distortion	IMD	$f_1 = 1.0003\text{MHz}$ , $f_2 = 0.99955\text{MHz}$		-84		dB
Full-Power Bandwidth		-3dB point		40		MHz
Full-Linear Bandwidth		SINAD > 68dB		2.5		MHz
Small-Signal Bandwidth				45		MHz

**Electrical Characteristics (continued)**

( $V_{DD} = 2.2V$  to  $3.6V$ ,  $V_{REF} = V_{DD}$ ,  $V_{OVDD} = V_{DD}$ ,  $f_{SCLK} = 48MHz$ , 50% duty cycle, 3Msps.  $C_{DOUT} = 10pF$ ,  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ , unless otherwise noted. Typical values are at  $T_A = +25^{\circ}C$ .)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
CONVERSION RATE						
Throughput			0.03		3	Msps
Conversion Time			260			ns
Acquisition Time	t <sub>ACQ</sub>		52			ns
Aperture Delay		From $\overline{CS}$ falling edge		4		ns
Aperture Jitter				15		ps
Serial-Clock Frequency	f <sub>CLK</sub>		0.48		48	MHz
ANALOG INPUT (AIN)						
Input Voltage Range	V <sub>AIN</sub>		0		V <sub>REF</sub>	V
Input Leakage Current	I <sub>ILA</sub>			0.002	±1	μA
Input Capacitance	C <sub>AIN</sub>	Track		20		pF
		Hold		5		
EXTERNAL REFERENCE INPUT (REF)						
Reference Input-Voltage Range	V <sub>REF</sub>		1		V <sub>DD</sub> + 0.05	V
Reference Input Leakage Current	I <sub>ILR</sub>	Conversion stopped		0.005	±1	μA
Reference Input Capacitance	C <sub>REF</sub>			5		pF
DIGITAL INPUTS (SCLK, $\overline{CS}$ )						
Digital Input High Voltage	V <sub>IH</sub>		0.75 × V <sub>OVDD</sub>			V
Digital Input Low Voltage	V <sub>IL</sub>			0.25 × V <sub>OVDD</sub>		V
Digital Input Hysteresis	V <sub>HYST</sub>			0.15 × V <sub>OVDD</sub>		V
Digital Input Leakage Current	I <sub>IL</sub>	Inputs at GND or V <sub>DD</sub>		0.001	±1	μA
Digital Input Capacitance	C <sub>IN</sub>			2		pF
DIGITAL OUTPUT (DOUT)						
Output High Voltage	V <sub>OH</sub>	I <sub>SOURCE</sub> = 1mA	0.85 × V <sub>OVDD</sub>			V
Output Low Voltage	V <sub>OL</sub>	I <sub>SINK</sub> = 5μA		0.15 × V <sub>OVDD</sub>		V
High-Impedance Leakage Current	I <sub>OL</sub>			±1.0		μA
High-Impedance Output Capacitance	C <sub>OUT</sub>			4		pF

**Electrical Characteristics (continued)**

( $V_{DD} = 2.2V$  to  $3.6V$ ,  $V_{REF} = V_{DD}$ ,  $V_{OVDD} = V_{DD}$ ,  $f_{SCLK} = 48MHz$ , 50% duty cycle, 3Msps.  $C_{DOUT} = 10pF$ ,  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ , unless otherwise noted. Typical values are at  $T_A = +25^{\circ}C$ .)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
<b>POWER SUPPLY</b>						
Positive Supply Voltage	$V_{DD}$		2.2		3.6	V
Digital I/O Supply Voltage	$V_{OVDD}$		1.5		$V_{DD}$	V
Positive Supply Current (Full-Power Mode)	$I_{VDD}$	$V_{AIN} = V_{GND}$			3.3	mA
	$I_{OVDD}$	$V_{AIN} = V_{GND}$			0.33	
Positive Supply Current (Full-Power Mode), No Clock	$I_{VDD}$			1.98		mA
Power-Down Current	$I_{PD}$	Leakage only		1.3	10	$\mu A$
Line Rejection		$V_{DD} = 2.2V$ to $3.6V$ , $V_{REF} = 2.2V$		0.7		LSB/V
<b>TIMING CHARACTERISTICS (Note 2)</b>						
Quiet Time	$t_Q$	(Note 3)	4			ns
$\overline{CS}$ Pulse Width	$t_1$	(Note 3)	10			ns
$\overline{CS}$ Fall to SCLK Setup	$t_2$	(Note 3)	5			ns
$\overline{CS}$ Falling Until DOUT High-Impedance Disabled	$t_3$	(Note 3)	1			ns
Data Access Time After SCLK Falling Edge	$t_4$	Figure 2, $V_{OVDD} = 2.2V$ to $3.6V$			15	ns
		Figure 2, $V_{OVDD} = 1.5V$ to $2.2V$			16.5	
SCLK Pulse Width Low	$t_5$	Percentage of clock period (Note 3)	40		60	%
SCLK Pulse Width High	$t_6$	Percentage of clock period (Note 3)	40		60	%
Data Hold Time From SCLK Falling Edge	$t_7$	Figure 3 (Note 3)	5			ns
SCLK Falling Until DOUT High-Impedance	$t_8$	Figure 4 (Note 3)	2.5		14	ns
Power-Up Time		Conversion cycle (Note 3)			1	Cycle

**Note 2:** All timing specifications given are with a 10pF capacitor.

**Note 3:** Guaranteed by design in characterization; not production tested.

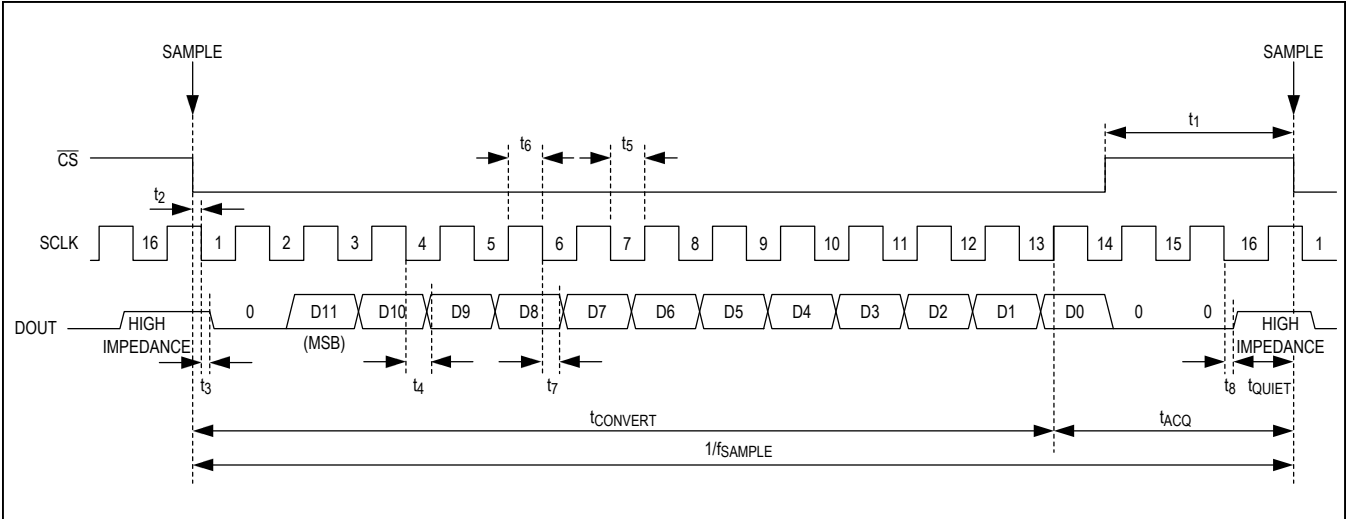


Figure 1. Interface Signals for Maximum Throughput

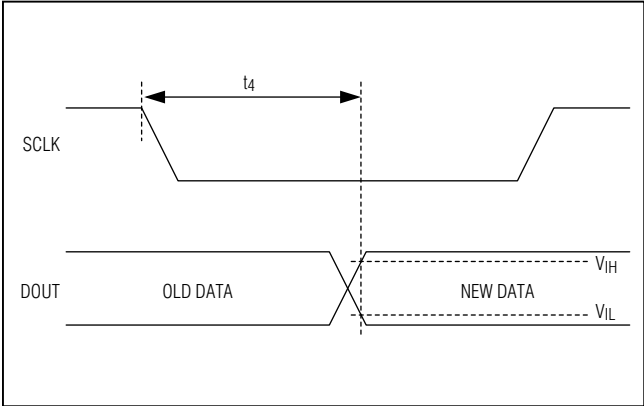


Figure 2. Setup Time After SCLK Falling Edge

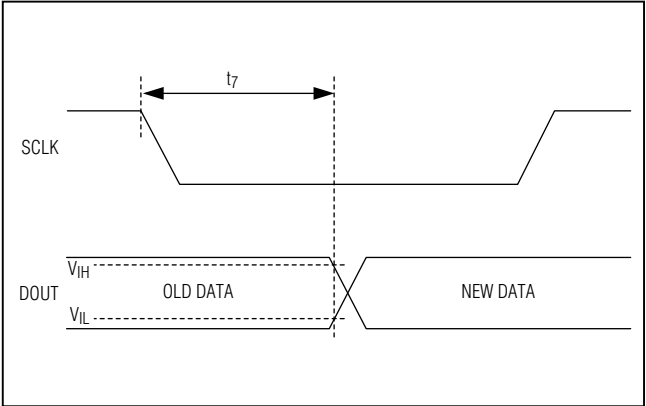


Figure 3. Hold Time After SCLK Falling Edge

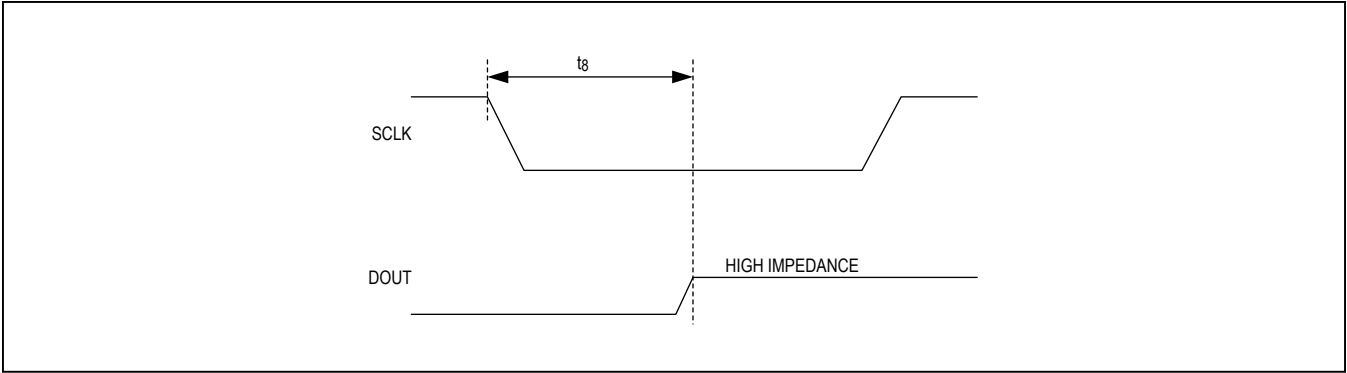
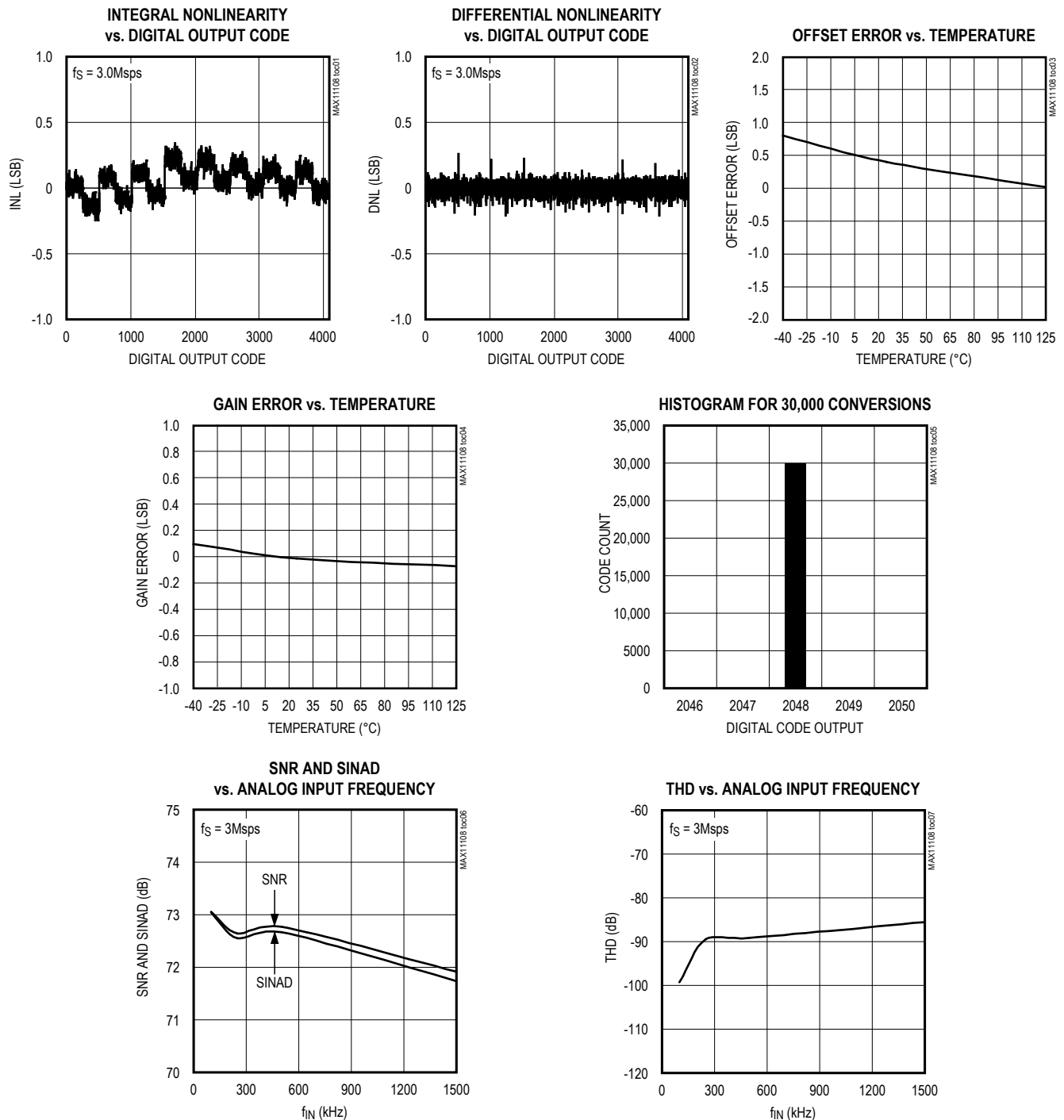


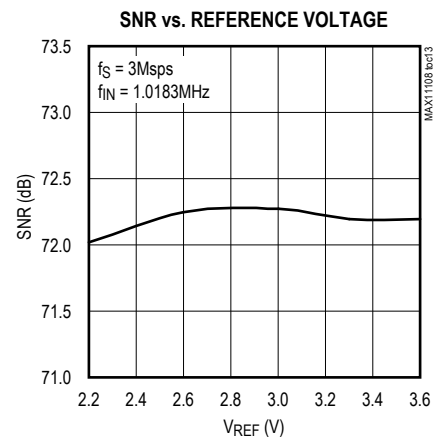
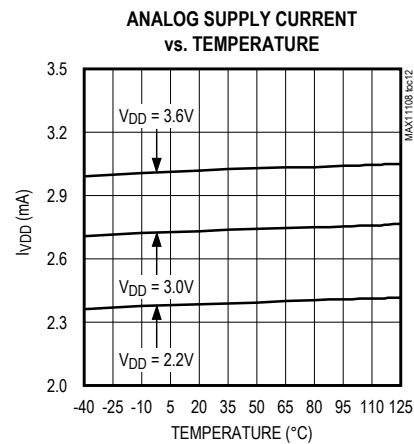
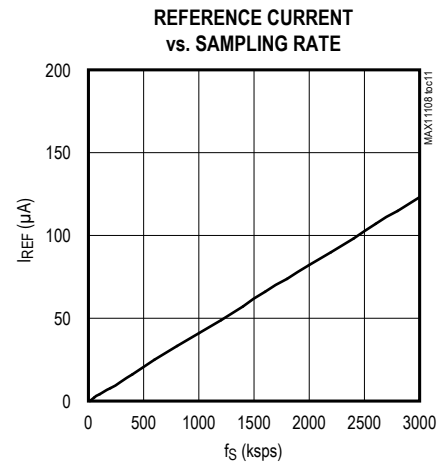
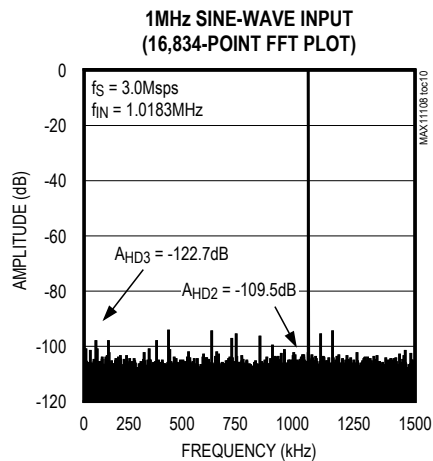
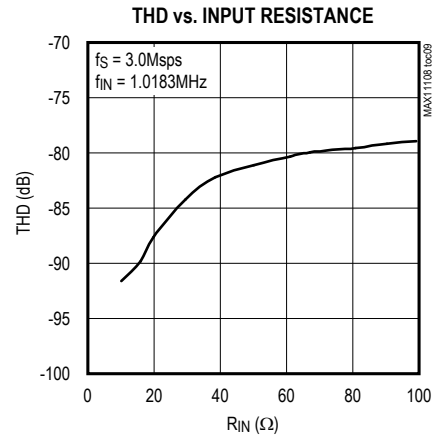
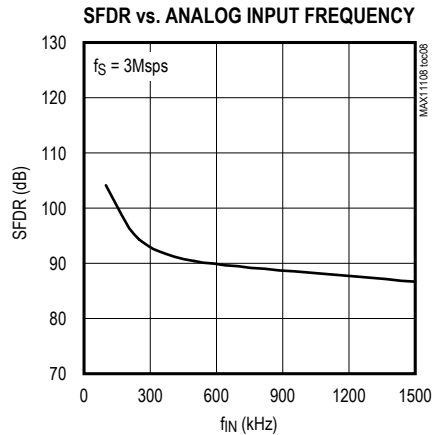
Figure 4. SCLK Falling Edge DOUT Three-State

## Typical Operating Characteristics

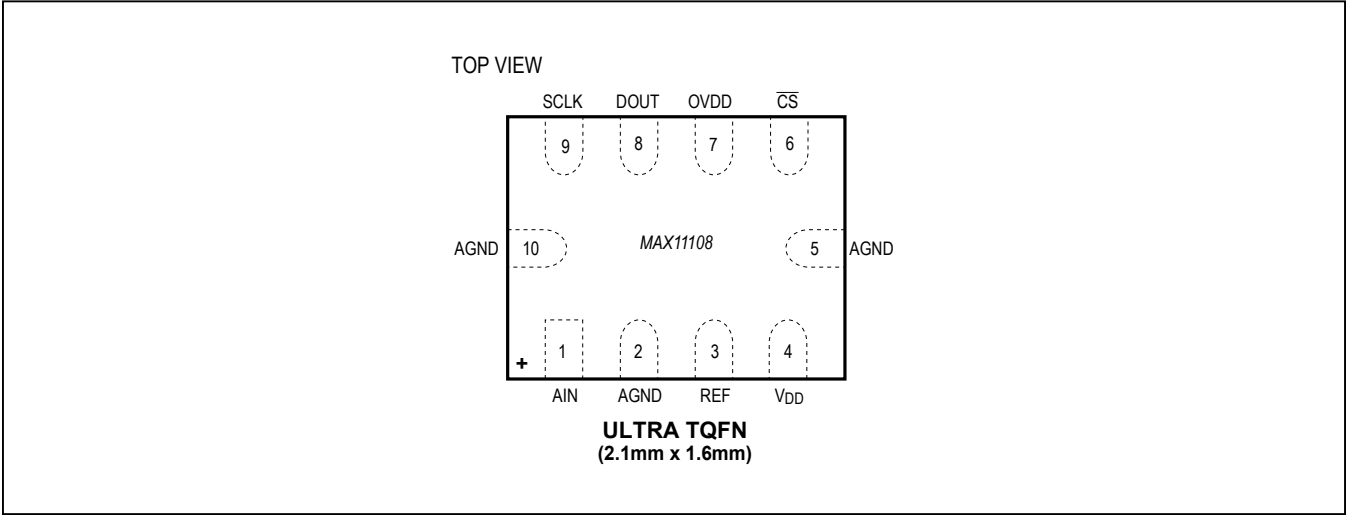
( $T_A = +25^\circ\text{C}$ , unless otherwise noted.)



## Typical Operating Characteristics (continued)

(T<sub>A</sub> = +25°C, unless otherwise noted.)

Pin Configuration

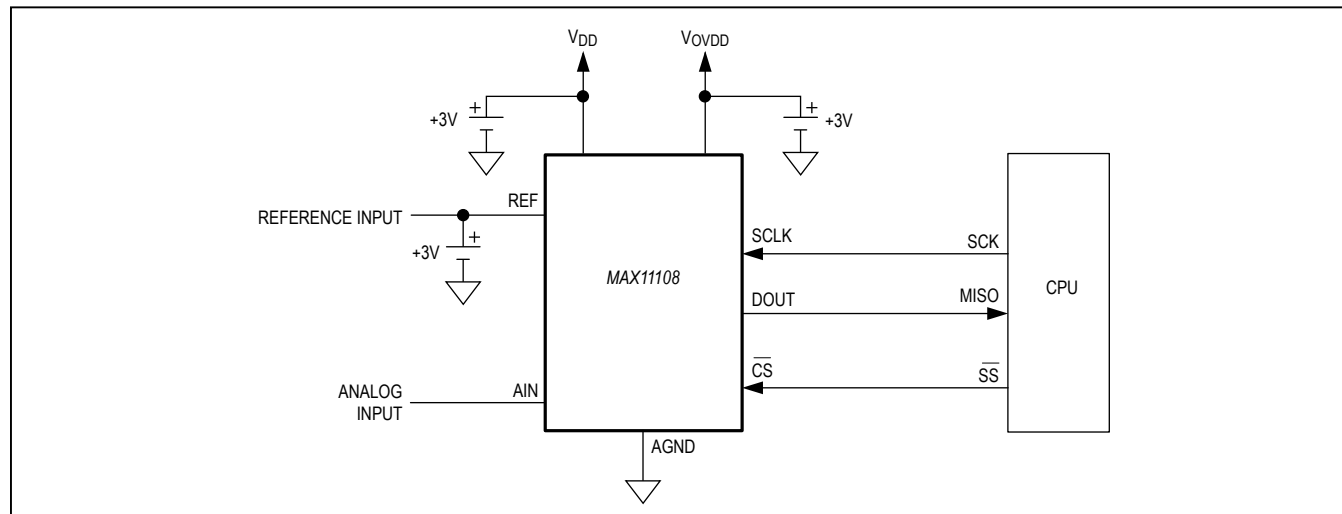


Pin Description

PIN	NAME	FUNCTION
1	AIN	Analog Single-Ended Input
2, 5, 10	AGND	Ground. This pin must connect to a solid ground plane.
3	REF	Reference Input Pin
4	V <sub>DD</sub>	Positive Supply Voltage
6	$\overline{\text{CS}}$	Chip Select (Active Low). Initiates acquisition on the falling edge.
7	OVDD	Digital I/O Supply Voltage ( $\overline{\text{CS}}$ , DOUT, SCLK).
8	DOUT	Serial Data Output. DOUT changes state on SCLK's falling edge. See Figures 1 to 4 for details.
9	SCLK	Serial Clock Input. SCLK drives the conversion process and clocks data out. See Figures 1 to 4 for details.



## Typical Operating Circuit



## Detailed Description

The MAX11108 is a tiny, fast, 12-bit, low-power, single-supply ADC. This device “communicates” from 1.5V to  $V_{DD}$ , operates from a 2.2V to 3.6V supply, and consumes only 9mW ( $V_{DD} = 3V$ )/6.6mW ( $V_{DD} = 2.2V$ ) at 3Msps. This 3Msps device is capable of sampling at full rate when driven by a 48MHz clock.

The conversion result appears at DOUT, MSB first, with a leading zero followed by the 12-bit result. A 12-bit result is followed by two trailing zeros (see Figure 1).

The device features a dedicated reference input (REF). The input signal range for AIN is defined as 0V to  $V_{REF}$  with respect to AGND.

This ADC includes a power-down feature allowing minimized power consumption at 2.5 $\mu$ A/ksps for lower throughput rates. The wake-up and power-down feature is controlled by using the SPI interface as described in the *Operating Modes* section.

### Serial Interface

This device features a 3-wire serial interface that directly connects to SPI/QSPI/MICROWIRE devices without external logic. Figure 1 shows the interface signals for a single conversion frame to achieve maximum throughput.

The falling edge of  $\overline{CS}$  defines the sampling instant. Once  $\overline{CS}$  transitions low, the external clock signal (SCLK) controls the conversion.

The SAR core successively extracts binary-weighted bits in every clock cycle. The MSB appears on the data bus during the 2nd clock cycle with a delay outlined in the timing specifications. All extracted data bits appear successively on the data bus with the LSB appearing during the 13th clock cycle for 12-bit operation. The serial data stream of conversion bits is preceded by a leading “zero” and succeeded by trailing “zeros.” The data output (DOUT) goes into high-impedance state during the 16th clock cycle.

To sustain the maximum sample rate, the device has to be resampled immediately after the 16th clock cycle. For lower sample rates, the  $\overline{CS}$  falling edge can be delayed leaving DOUT in a high-impedance condition. Pull  $\overline{CS}$  high after the 10th SCLK falling edge (see the *Operating Modes* section).

### Analog Input

The ADC produces a digital output that corresponds to the analog input voltage within the specified operating range of 0 to  $V_{REF}$ .

Figure 5 shows an equivalent circuit for the analog input AIN. Internal protection diodes D1/D2 confine the analog input voltage within the power rails ( $V_{DD}$ , AGND). The analog input voltage can swing from (AGND - 0.3V) to ( $V_{DD} + 0.3V$ ) without damaging the device.

The electric load presented to the external stage driving the analog input varies depending on which mode the ADC is in: track mode vs. conversion mode. In track mode, the internal sampling capacitor  $C_S$  (16pF) has

to be charged through the resistor R ( $50\Omega$ ) to the input voltage. For faithful sampling of the input, the capacitor voltage on  $C_S$  has to settle to the required accuracy during the track time.

The source impedance of the external driving stage in conjunction with the sampling switch resistance affects the settling performance. The THD vs. Input Resistance graph in the *Typical Operating Characteristics* shows THD sensitivity as a function of the signal source impedance. Keep the source impedance at a minimum for high-dynamic performance applications. Use a high-performance op amp such as the MAX4430 to drive the analog input, thereby decoupling the signal source and the ADC.

While the ADC is in conversion mode, the sampling switch is open presenting a pin capacitance,  $C_P$  ( $C_P = 5\text{pF}$ ), to the driving stage. See the *Applications Information* section for information on choosing an appropriate buffer for the ADC.

### ADC Transfer Function

The output format is straight binary. The code transitions midway between successive integer LSB values such as 0.5 LSB, 1.5 LSB, etc. The LSB size is  $V_{REF}/2^n$  where  $n = 12$ . The ideal transfer characteristic is shown in Figure 9.

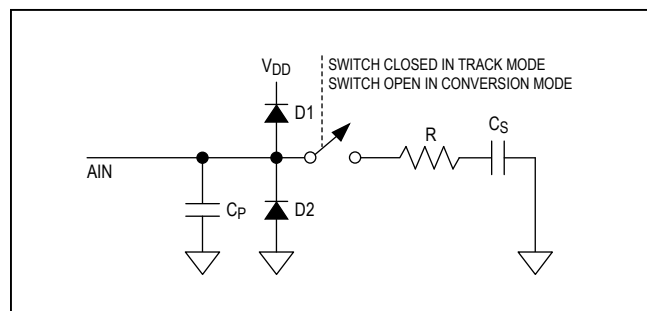


Figure 5. Analog Input Circuit

### Operating Modes

The IC offers two modes of operation: normal mode and power-down mode. The logic state of the  $\overline{CS}$  signal during a conversion activates these modes. The power-down mode can be used to optimize power dissipation with respect to sample rate.

#### Normal Mode

In normal mode, the device is powered up at all times, thereby achieving its maximum throughput rates. Figure 6 shows the timing diagram in normal mode. The falling edge of  $\overline{CS}$  samples the analog input signal, starts a conversion, and frames the serial data transfer.

To remain in normal mode, keep  $\overline{CS}$  low until the falling edge of the 10th SCLK cycle. Pulling  $\overline{CS}$  high after the 10th SCLK falling edge keeps the part in normal mode. However, pulling  $\overline{CS}$  high before the 10th SCLK falling edge terminates the conversion, DOUT goes into high-impedance mode, and the device enters power-down mode. See Figure 7.

#### Power-Down Mode

In power-down mode, all bias circuitry is shut down drawing typically only  $1.3\mu\text{A}$  of leakage current. To save power, put the device in power-down mode between conversions. Using the power-down mode between conversions is ideal for saving power when sampling the analog input infrequently.

#### Entering Power-Down Mode

To enter power-down mode, drive  $\overline{CS}$  high between the 2nd and 10th falling edges of SCLK (see Figure 7). By pulling  $\overline{CS}$  high, the current conversion terminates and DOUT enters high impedance.

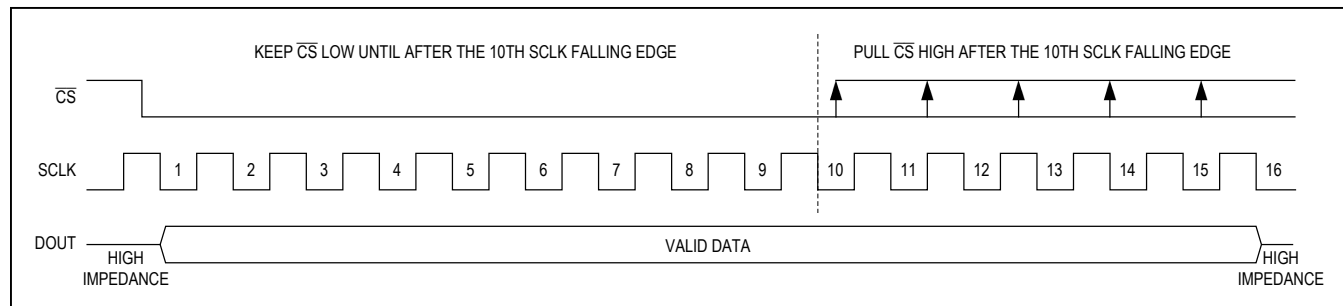


Figure 6. Normal Mode

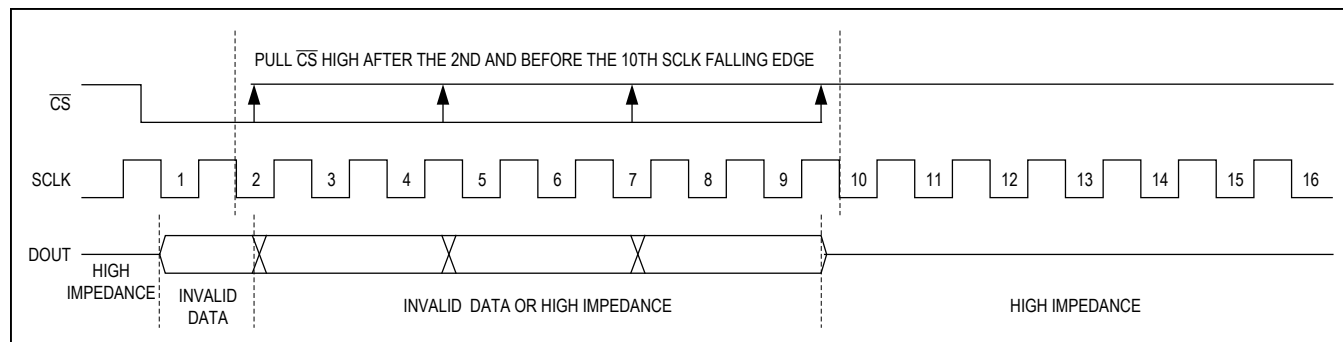


Figure 7. Entering Power-Down Mode

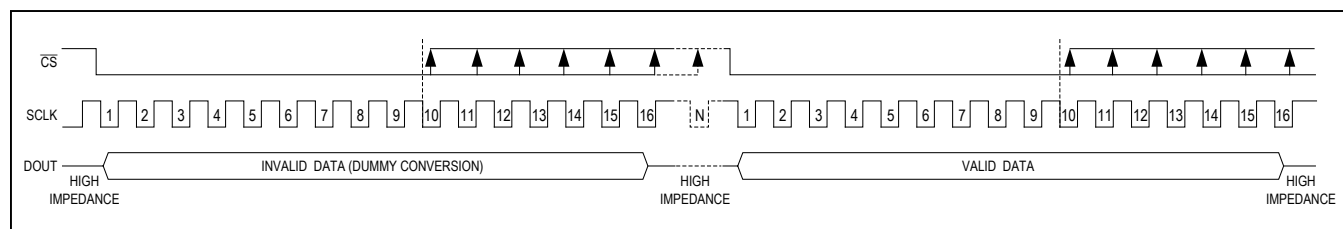


Figure 8. Exiting Power-Down Mode

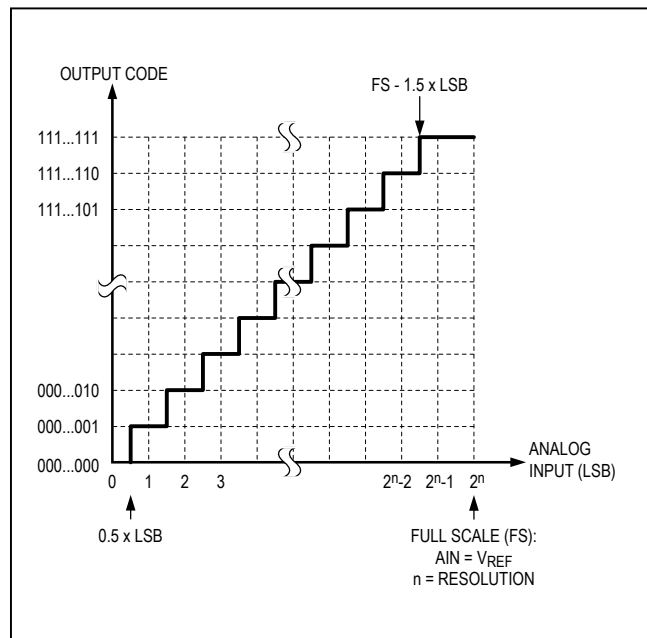


Figure 9. ADC Transfer Function

### Exiting Power-Down Mode

To exit power-down mode, implement one dummy conversion by driving  $\overline{CS}$  low for at least 10 clock cycles (see Figure 8). The data on DOUT is invalid during this dummy conversion. The first conversion following the dummy cycle contains a valid conversion result.

The power-up time equals the duration of the dummy cycle, and is dependent on the clock frequency. The power-up time for 3Msps operation (48MHz SCLK) is 333ns.

### Supply Current vs. Sampling Rate

For applications requiring lower throughput rates, the user can reduce the clock frequency ( $f_{SCLK}$ ) to lower the sample rate. Figure 10 shows the typical supply current ( $I_{VDD}$ ) as a function of sample rate ( $f_S$ ). The part operates in normal mode and is never powered down.

The user can also power down the ADC between conversions by using the power-down mode. Figure 11 shows that as the sample rate is reduced, the device remains in the power-down state longer and the average supply current ( $I_{VDD}$ ) drops accordingly.

### 14-Cycle Conversion Mode

The ICs can operate with 14 cycles per conversion. Figure 12 shows the corresponding timing diagram. Observe that DOUT does not go into high-impedance mode. Also, observe that  $t_{ACQ}$  needs to be sufficiently long to guarantee proper settling of the analog input voltage. See the *Electrical Characteristics* table for  $t_{ACQ}$  requirements and the *Analog Input* section for a description of the analog inputs.

## Applications Information

### Layout, Grounding, and Bypassing

For best performance, use PCBs with a solid ground plane. Ensure that digital and analog signal lines are separated from each other. Do not run analog and digital (especially clock) lines parallel to one another or digital lines underneath the ADC package. Noise in the  $V_{DD}$  power supply, OVDD, and REF affects the ADC's performance. Bypass the  $V_{DD}$ , OVDD, and REF to ground with 0.1 $\mu$ F and 10 $\mu$ F bypass capacitors. Minimize capacitor lead and trace lengths for best supply-noise rejection.

### Choosing an Input Amplifier

It is important to match the settling time of the input amplifier to the acquisition time of the ADC. The conversion results are accurate when the ADC samples the input signal for an interval longer than the input signal's worst-case settling time. By definition, settling time is the interval between the application of an input voltage

step and the point at which the output signal reaches and stays within a given error band centered on the resulting steady-state amplifier output level. The ADC input sampling capacitor charges during the sampling cycle, referred to as the acquisition period. During this acquisition period, the settling time is affected by the input resistance and the input sampling capacitance. This error can be estimated by looking at the settling of an RC time constant using the input capacitance and the source impedance over the acquisition time period.

Figure 13 shows a typical application circuit. The MAX4430, offering a settling time of 37ns at 16 bits, is an excellent choice for this application. See the THD vs. Input Resistance graph in the *Typical Operating Characteristics*.

### Choosing a Reference

For devices using an external reference, the choice of the reference determines the output accuracy of the ADC. An ideal voltage reference provides a perfect initial accuracy and maintains the reference voltage independent of changes in load current, temperature, and time. Considerations in selecting a reference include initial voltage accuracy, temperature drift, current source, sink capability, quiescent current, and noise. Figure 13 shows a typical application circuit using the MAX6126 to provide the reference voltage. The MAX6033 and MAX6043 are also excellent choices.

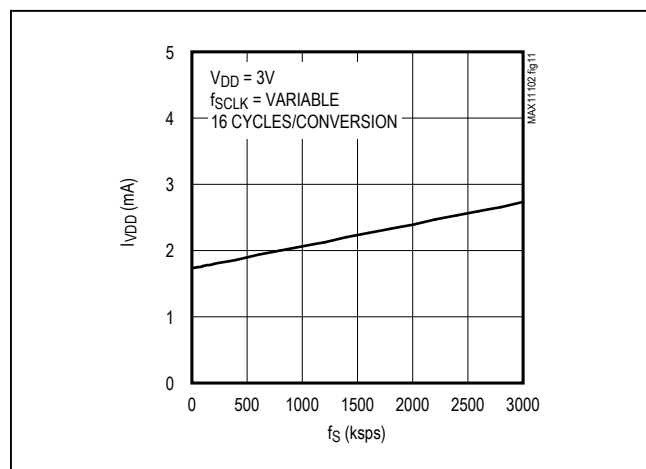


Figure 10. Supply Current vs. Sample Rate (Normal Operating Mode, 3Msps Devices)

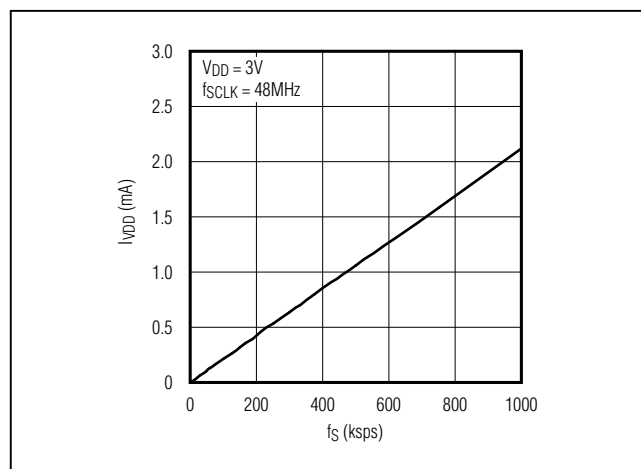


Figure 11. Supply Current vs. Sample Rate (Device Powered Down Between Conversions, 3Msps Devices)

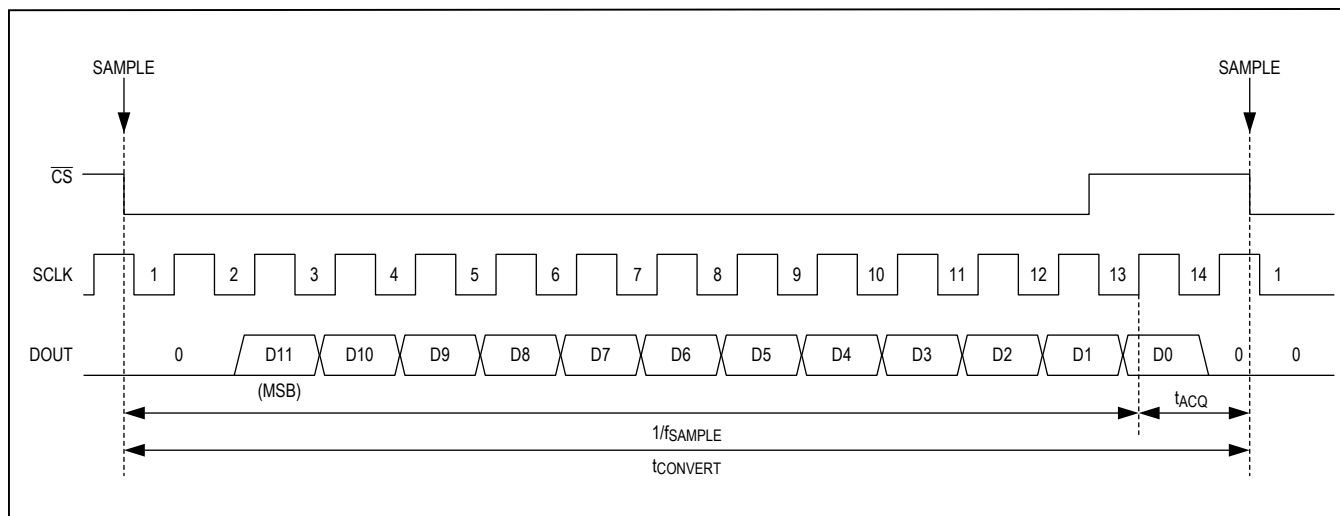


Figure 12. 14-Clock Cycle Operation

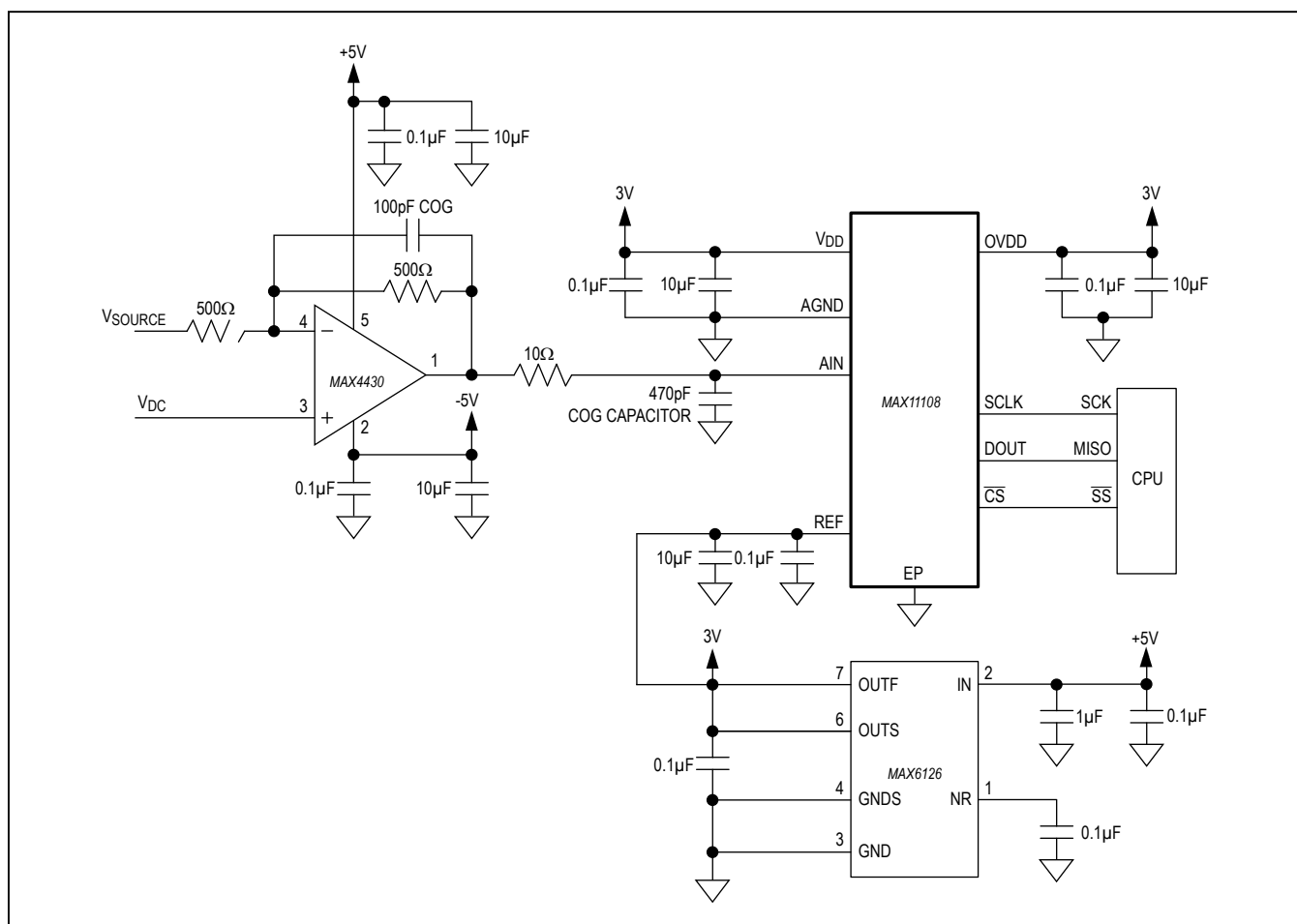


Figure 13. Typical Application Circuit

## Definitions

### Integral Nonlinearity

Integral nonlinearity (INL) is the deviation of the values on an actual transfer function from a straight line. For these devices, the straight line is a line drawn between the end points of the transfer function after offset and gain errors are nulled.

### Differential Nonlinearity

Differential nonlinearity (DNL) is the difference between an actual step width and the ideal value of 1 LSB. A DNL error specification of  $\pm 1$  LSB or less guarantees no missing codes and a monotonic transfer function.

### Offset Error

The deviation of the first code transition (00 . . . 000) to (00 . . . 001) from the ideal, that is, AGND + 0.5 LSB.

### Gain Error

The deviation of the last code transition (111 . . . 110) to (111 . . . 111) from the ideal after adjusting for the offset error, that is,  $V_{REF} - 1.5$  LSB.

### Aperture Jitter

Aperture jitter ( $t_{AJ}$ ) is the sample-to-sample variation in the time between the samples.

### Aperture Delay

Aperture delay ( $t_{AD}$ ) is the time between the falling edge of sampling clock and the instant when an actual sample is taken.

### Signal-to-Noise Ratio (SNR)

SNR is a dynamic figure of merit that indicates the converter's noise performance. For a waveform perfectly reconstructed from digital samples, the theoretical maximum SNR is the ratio of the full-scale analog input (RMS value) to the RMS quantization error (residual error). The ideal, theoretical minimum analog-to-digital noise is caused by quantization error only and results directly from the ADC's resolution (N bits):

$$\text{SNR (dB) (MAX)} = (6.02 \times N + 1.76) \text{ (dB)}$$

In reality, there are other noise sources such as thermal noise, reference noise, and clock jitter that also degrade SNR. SNR is computed by taking the ratio of the RMS signal to the RMS noise. RMS noise includes all spectral components to the Nyquist frequency excluding the fundamental, 2nd to 5th harmonic, and the DC offset.

### Signal-to-Noise Ratio and Distortion (SINAD)

SINAD is a dynamic figure of merit that indicates the converter's noise and distortion performance. SINAD is computed by taking the ratio of the RMS signal to the RMS noise plus distortion. RMS noise plus distortion includes all spectral components to the Nyquist frequency excluding the fundamental and the DC offset:

$$\text{SINAD(dB)} = 20 \times \log \left[ \frac{\text{SIGNAL}_{\text{RMS}}}{(\text{NOISE} + \text{DISTORTION})_{\text{RMS}}} \right]$$

### Total Harmonic Distortion

Total harmonic distortion (THD) is the ratio of the RMS sum of the first four harmonics of the input signal to the fundamental itself. This is expressed as:

$$\text{THD} = 20 \times \log \left( \frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + V_5^2}}{V_1} \right)$$

where  $V_1$  is the fundamental amplitude and  $V_2$ – $V_5$  are the amplitudes of the 2nd- through 5th-order harmonics.

### Spurious-Free Dynamic Range (SFDR)

SFDR is a dynamic figure of merit that indicates the lowest usable input signal amplitude. SFDR is the ratio of the RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next largest spurious component, excluding DC offset. SFDR is specified in decibels with respect to the carrier (dBc).

### Full-Power Bandwidth

Full-power bandwidth is the frequency at which the input signal amplitude attenuates by 3dB for a full-scale input.

### Full-Linear Bandwidth

Full-linear bandwidth is the frequency at which the signal-to-noise ratio and distortion (SINAD) is equal to a specified value.

### Intermodulation Distortion

Any device with nonlinearities creates distortion products when two sine waves at two different frequencies ( $f_1$  and  $f_2$ ) are applied into the device. Intermodulation distortion (IMD) is the total power of the IM2 to IM5 intermodulation products to the Nyquist frequency relative to the total input power of the two input tones,  $f_1$  and  $f_2$ . The individual input tone levels are at -6dBFS.

MAX11108

Tiny, 2.1mm x 1.6mm, 3Msps,  
Low-Power, Serial 12-Bit ADC

## Ordering Information

PART	PIN-PACKAGE	BITS	SPEED (Msps)	NO. OF CHANNELS	TOP MARK
MAX11108AVB+T	10 Ultra TQFN	12	3	1	+ABC

**Note:** This device is specified over the -40°C to +125°C operating temperature range.

+Denotes a lead(Pb)-free/RoHS-compliant package.

T = Tape and reel.

## Chip Information

PROCESS: BiCMOS

## Package Information

For the latest package outline information and land patterns (footprints), go to [www.maximintegrated.com/packages](http://www.maximintegrated.com/packages). Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE TYPE	PACKAGE CODE	OUTLINE NO.	LAND PATTERN NO.
10 Ultra TQFN	V101A2CN+1	<a href="#">21-0610</a>	<a href="#">90-0386</a>

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## Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	9/12	Initial release	—
1	4/13	Updated data sheet	1–4, 8–15
2	12/14	Revised <i>Benefits and Features</i> section	1
3	3/15	Removed automotive reference from data sheet	1

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim Integrated's website at [www.maximintegrated.com](http://www.maximintegrated.com).

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- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



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